

<b>Notice of References Cited</b>	Application/Control No. 09/847,063	Applicant(s)/Patent Under Reexamination ZHOU ET AL.	
	Examiner J. Derek Rutten	Art Unit 2192	Page 1 of 1

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*	C	US-2001/0044809 a1	11-2001	Parasnis et al.	707/513
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	M	US-			

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**NON-PATENT DOCUMENTS**

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